Search Notes



Application/Control No.	Applicant(s)/Patent under Reexamination	
10/007,065	MARTINEZ ET AL.	
Examiner	Art Unit	
Farzana E. Hossain	2623	_

	SEARCHED		
Class	Subclass	Date	Examiner
725	109	12/14/2005	FEH
725	133	12/14/2005	FEH
725	141	12/14/2005	FEH
725	153	12/14/2005	FEH
725	59	12/15/2005	FEH
725	133	4/5/2006	FEH
725	141	4/5/2006	FEH
725	153	4/5/2006	FEH
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TAI	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
725	133	4/5/2006	FEH
725	141	4/5/2006	FEH
725	153	4/5/2006	FEH
	e\$1 same e array).clm.	4/5/2006	FEH

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
See Enclosed East Search	12/16/2005	FEH
Chris Kelley of Class 725	12/16/2005	FEH
Ngoc Vu of Class 725	12/16/2005	FEH
Tilahun Gesesse of Class 455	12/16/2005	FEH
Andrew Caldwell of Class 709	12/16/2005	FEH
Ray Bayerl of Class 715	12/16/2005	FEH
Chris Kelley of Class 725	4/5/2006	FEH
Vivek Srivastava of Class 725	4/6/2006	FEH

Search Notes (continued)

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10/007,065	MARTINEZ ET AL.	
Examiner	Art Unit	
Farzana E Hossain	2623	

	SEARCHED		
Class	Subclass	Date	Examiner
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
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